Search Notes			

	Application/Control No.	Applicant(s)/Patent under Reexamination
j	10/044,195	SYED, MAJID
	Examiner	Art Unit

Thuong (Tina) T. Nguyen

2155

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	SEARCHED		
Class	Subclass	Date	Examiner
709	225,226, 231	11/28/2006	тн
725	85	11/28/2006	TH
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH (INCLUDING SEA	I NOTES RCH STRATEGY)
	DATE	EXMR
EAST	11/28/2006	тн
IEEE	11/28/2006	тн
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